1MB R4000 Secondary Cache Fast Static RAM Module Set

Four MCM4464 modules comprise a full 1 MB of secondary cache for the R4000 processor. Each module contains nine MCM6709J fast static RAMs for a cache data size of 64K x 36. The tag portion, dependent on word line size, contains either two MCM6709J or one MCM6706J fast static RAMs. All input signals, except A0 and \overline{WE} are buffered using 74FBT2827 drivers with series 25 Ω resistors

The MCM6709J and MCM6706J are fabricated using high–performance silicon–gate BiCMOS technology. Static design eliminates the need for internal clocks or timing strobes.

All 1MB R4000 supported secondary cache options are available.

- Single 5 V ± 10% Power Supply
- · All Inputs and Outputs are TTL Compatible
- Three State Outputs
- Fast Module Access Time: 12/15/17 ns
- Zero Wait-State Operation
- Unified or Split Seconday Cache Modules are Available (See Ordering Information for Details)
- Word Line Sizes of 4, 8, 16, and 32 are Available (See Ordering Information for Details)
- The Pin Compatible MCM44256 Series is also Available to Support a Full 4MB R4000 Secondary Cache.
- Decoupling Capacitors are Used for Each Fast Static RAM and Buffer, Along with Bulk Capacitance for Maximum Noise Immunity
- High Quality Multi–Layer FR4 PWB with Separate Power and Ground Planes

PIN NAMES
A0 - A15 Address Inputs WE Write Enable DCS Data Enable TCS Tag Enable OE Output Enable DQ0 - DQ35 Data Input / Output TDQ0 - TDQ7 TAG Data Input / Output VCC + 5 V Power Supply VSS Ground

For proper operation of the device, V_{SS} must be connected to ground.

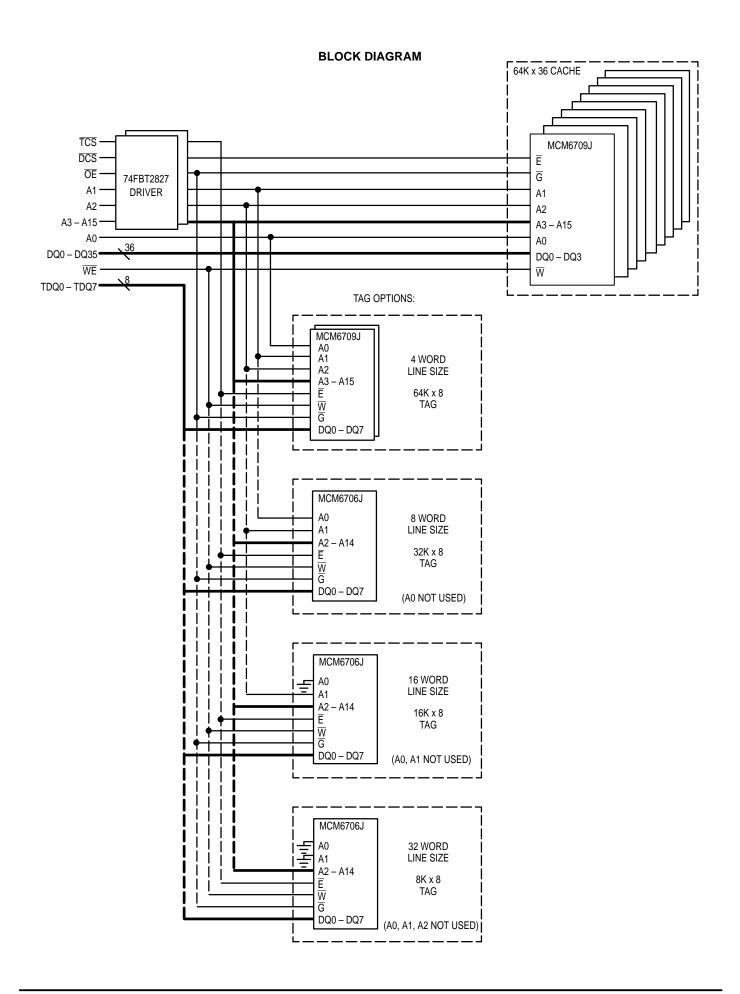
MCM4464 Series

PIN ASSIGNMENT							
80 LEAD	SIMM -	<u> ТО</u> F	VIEW				
Voo	2	1	V_{SS}				
V _{CC} DQ1	4	3	DQ0				
DQ3	6	5	DQ2				
DQ5	8	7	DQ4				
Vss	10	9	DQ6				
DQ8	12	11	DQ7				
DQ10	14	13	DQ9				
DQ12	16	15	DQ11				
DQ14	18	17	DQ13				
DQ15	20	19	V_{SS}				
DQ17	22	21	DQ16				
DQ19	24	23	DQ18				
DQ21	26	25	DQ20				
V _{SS}	28	27	DQ22				
DQ23	30	29	VCC				
DQ25	32	31	DQ24				
DQ27	34	33	DQ26				
DQ29	36	35	DQ28				
DQ30	38	37	V_{SS}				
DQ32	40	39	DQ31				
DQ34	42	41	DQ33				
V _{SS}	44	43	DQ35				
A0	46	45	WE				
A2	48	47	A1				
A4	50	49	A3				
A6	52	51	A5				
Vcc	54	53	V _{SS}				
ŌE	56	55	DCS				
A8	58	57	A7				
A10	60	59	A9				
V_{SS}	62	61	A11				
A13	64	63	A12				
A15	66*	65	A14				
NC	68*	67	NC				
TDQ0	70	69	TCS				
TDQ1	72	71	VSS				
TDQ3	74	73	TDQ2				
TDQ5	76	75	TDQ4				
TDQ7	78	77	TDQ6				
V_{SS}	80	79	VCC				
NOTE: Pin assi	gnment is	for unif	ied cache. For				

NOTE: Pin assignment is for unified cache. For split cache option, Pin 68 becomes Address MSB (A15) and Pin 66 is NC.

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ABSOLUTE MAXIMUM RATINGS (Voltages Referenced to VSS = 0 V)

Rating	Symbol	Value	Unit
Power Supply Voltage	Vcc	- 0.5 to 7.0	V
Voltage Relative to VSS	V _{in} , V _{out}	-0.5 to V _{CC} + 0.5	V
Output Current (per I/O)	l _{out}	± 30	mA
Power Dissipation	PD	10	W
Temperature Under Bias	T _{bias}	- 10 to + 85	°C
Operating Temperature	T _A	0 to + 70	°C
Storage Temperature	T _{stg}	- 25 to +125	°C

NOTE: Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPER-ATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability.

This devices on this module contain circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to these high–impedance circuits.

These BiCMOS memory circuits have been designed to meet the dc and ac specifications shown in the tables, after thermal equilibrium has been established. The module is in a test socket or mounted on a printed circuit board and transverse air flow of at leat 500 linear feet per minute is maintained.

DC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{CC} = 5.0 V \pm 10%, T_A = 0 to + 70°C, Unless Otherwise Noted)

RECOMMENDED OPERATING CONDITIONS (Voltages referenced to V_{SS} = 0 V)

Parameter	Symbol	Min	Тур	Max	Unit
Supply Voltage (Operating Voltage Range)	VCC	4.5	5.0	5.5	V
Input High Voltage (DQ0 – 35, TDQ0 – 7, WE, A0) (A1 – A15, OE, DCS, TCS)	VIH	2.2 2.0	1	V _{CC} + 0.3 V* V _{CC} + 0.3 V*	V
Input Low Voltage	VIL	- 0.5**	_	0.8	V

^{*} V_{IH} (max) = V_{CC} + 0.3 V dc; V_{IH} (max) = V_{CC} + 2 V ac (pulse width \leq 20 ns)

DC CHARACTERISTICS

Parameter	Symbol	Min	Тур	Max	Unit
Input Leakage Current (All Inputs, V _{in} = 0 to V _{CC})	I _{lkg(I)}		_	± 10	μΑ
Output Leakage Current (\overline{G} , $\overline{xCS} = V_{IH}$, $V_{Out} = 0$ to V_{CC})	Ilkg(O)		_	± 10	μА
AC Supply Current $(\overline{G}, \overline{xCS} = V_{IL}, I_{Out} = 0 \text{ mA})$	ICCA		_	1850	mA
Output Low Voltage (I _{OL} = + 8 mA)	VOL		_	0.4	V
OUtput High Voltage (I _{OH} = - 4.0 mA)	VOH	2.4	_	_	V

Note: Good decoupling of the local power supply should always be used.

CAPACITANCE (f = 1.0 MHz, dV = 3.0 V, T_A = 25°C, Periodically Sampled Rather Than 100% Tested)

	Parameter	Symbol	Тур	Max	Unit
Input Capacitance	$(A0, \overline{WE})$ $(A1 - A15, \overline{OE}, \overline{DCS}, \overline{TCS})$	C _{in} C _{in}	_	110 10	pF pF
Input/Output Capacitance	· · · · · · · · · · · · · · · · · · ·	C _{out}	_	10	pF

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^{**} V_{IL} (min) = -3.0 V ac (pulse width ≤ 20 ns)

AC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{CC} = $5.0 \text{ V} \pm 10\%$, T_A = $0 \text{ to} + 70^{\circ}\text{C}$, Unless Otherwise Noted)

Input Timing Measurement Reference Level 1.5 V	Output Timing Measurement Reference Level 1.5 V
Input Pulse Levels	Output Load See Figure 1A
Input Rise/Fall Time 3 ns	

READ CYCLE (See Notes 1 and 2)

		-12		-12 -15			17		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Address Access Time	†AVQV	_	12	_	15	_	17	ns	
A0 Access Time	tA0QV	_	10	_	12	_	14	ns	
Data/Tag Enable Access Time	t _{ELQV}	_	12	_	15	_	17	ns	
Output Enable Access Time	tGLQV	_	9	_	10		11	ns	
Output Hold from Address Change	t _{AXQX}	4	_	4	_	4	_	ns	
Output Hold from A0 Change	t _{A0XQX}	4	_	4	_	4	_	ns	
Data/Tag Enable Low to Output Active	t _{ELQX}	2	_	2	_	2	_	ns	3, 4
Data/Tag Enable High to Output High–Z	t _{EHQZ}	1	9	1	10	1	11	ns	3, 4
Output Enable Low to Output Active	tGLQX	1	_	1	_	1	_	ns	3, 4
Output Enable High to Output High–Z	^t GHQZ	1	9	1	10	1	11	ns	3, 4

NOTES:

- 1. WE is high for read cycle.
- 2. Enable timings are the same for both \overline{DCS} and \overline{TCS} .
- 3. Transition is measured 200 mV from steady-state voltage with load of Figure 1B.
- 4. This parameter is sampled and not 100% tested.

AC TEST LOADS

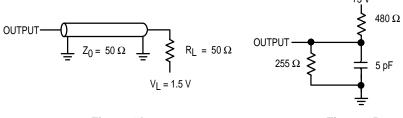


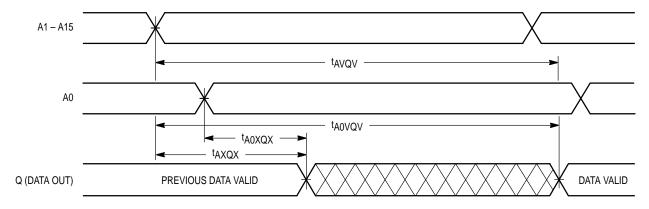
Figure 1A Figure 1B

TIMING LIMITS

The table of timing values shows either a minimum or a maximum limit for each parameter. Input requirements are specified from the external system point of view. Thus, address setup time is shown as a minimum since the system must supply at least that much time (even though most devices do not require it). On the other hand, responses from the memory are specified from the device point of view. Thus, the access time is shown as a maximum since the device never provides data later than that time.

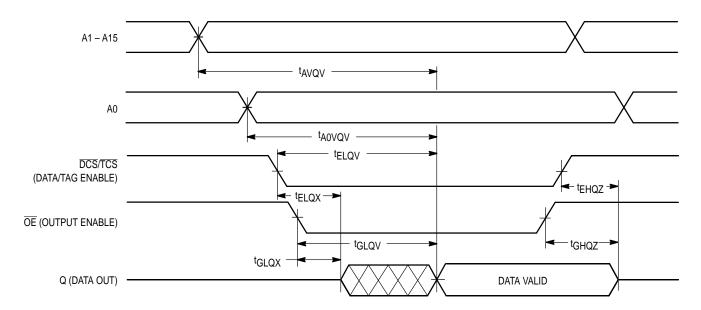
MCM4464 SERIES MOTOROLA FAST SRAM

READ CYCLE 1 (See Note)



NOTE: Module is continuously selected (\overline{DCS} or $\overline{TCS} = V_{|L}$, $\overline{OE} = V_{|L}$).

READ CYCLE 2 (See Note)



NOTE: Address valid prior to or coincident with $\overline{\text{DCS}}$ or $\overline{\text{TCS}}$ going low.

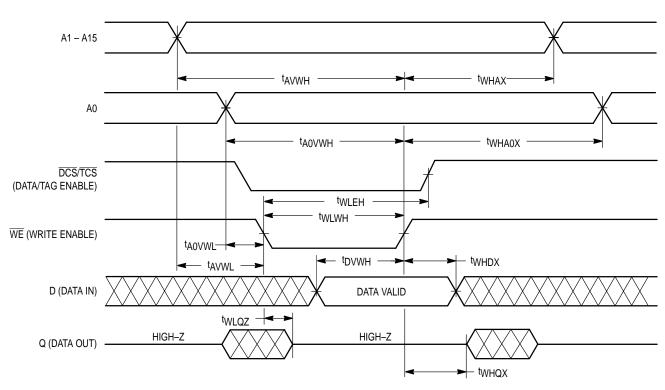
WRITE CYCLE 1 (WE Controlled, See Notes 1 and 2)

		-12		-12 –15			-17		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes
Address Setup Time	tAVWL	5	_	5	_	5	_	ns	
A0 Setup Time	tA0VWL	0	_	0	_	0	_	ns	
Address Valid to End of Write	^t AVWH	12	_	15	_	17	_	ns	
A0 Valid to End of Write	tA0VWH	10	_	12	_	14	_	ns	
Write Pulse Width	tWLWH tWLEH	7	_	10	_	12	_	ns	
Data Valid to End of Write	^t DVWH	6	_	7	_	8	_	ns	
Data Hold Time	tWHDX	0	_	0	_	0	_	ns	
Write Low to Data High–Z	tWLQZ	0	4	0	5	0	6	ns	3, 4
Write High to Output Active	tWHQX	3	_	3	_	3	_	ns	3, 4
Write Recovery Time	tWHAX	0	_	0	_	0	_	ns	_
Write Recovery Time – A0	tWHA0X	0	_	0	_	0	_	ns	

NOTES:

- 1. A write occurs during the overlap of $\overline{\text{DCS}}$ or $\overline{\text{TCS}}$ low and $\overline{\text{WE}}$ low.
- 2. Enable timings are the same for both \overline{DCS} and \overline{TCS} .
- 3. Transition is measured 200 mV from steady–state voltage with load of Figure 1B.
- 4. This parameter is sampled and not 100% tested.

WRITE CYCLE 1



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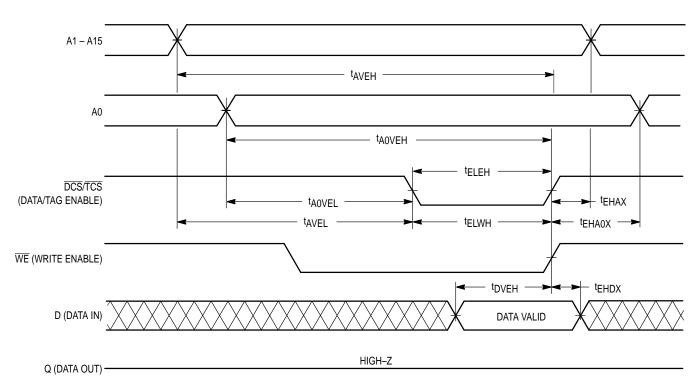
WRITE CYCLE 2 (\overline{DCS} or \overline{TCS} Controlled, See Notes 1 and 2)

		-12		-12 -15		-15 -17		17		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Unit	Notes	
Address Setup Time	^t AVEL	0	_	0	_	0	_	ns		
A0 Setup Time	^t A0VEL	0	_	0	_	0	_	ns		
Address Valid to End of Write	^t AVEH	12	_	15	_	17	_	ns		
A0 Valid to End of Write	^t A0VEH	10	_	12	_	14	_	ns		
Data/Tag Enable to End of Write	^t ELEH, ^t ELWH	12	_	15	_	17	_	ns		
Data Valid to End of Write	^t DVEH	6	_	7	_	8	_	ns		
Data Hold Time	t _{EHDX}	5	_	5	_	5	_	ns		
Write Recovery Time	t _{EHAX}	5	_	5	_	5	_	ns		
Write Recovery Time – A0	tEHA0X	5	_	5	_	5	_	ns		

NOTES:

- A write occurs during the overlap of DCS or TCS low and WE low.
 Enable timings are the same for both DCS and TCS.

WRITE CYCLE 2



MOTOROLA FAST SRAM MCM4464 SERIES

ORDERING INFORMATION (Order by Full Part Number)

	<u>MÇM</u>	<u>44X64</u>	<u> </u>	<u> </u>	
Motorola Memory Prefix					— Speed (12 = 12 ns, 15 = 15 ns, 17 = 17 ns)
Part Number					_ Package (SG = Gold Pad SIMM)

Part Number	Unified/Split	Word Line Size	TAG Depth
MCM44A64	Unified	4	64K
MCM44B64	Unified	8	32K
MCM44C64	Unified	16	16K
MCM44D64	Unified	32	8K
MCM44E64	Split	4	64K
MCM44F64	Split	8	32K
MCM44G64	Spllit	16	16K
MCM44H64	Split	32	8K

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